MOSFET, N-Channel, Shielded Gate, PowerTrench[®]

120 V, 53 m Ω , 4.5 A, Single N–Channel

Features

- Shielded Gate MOSFET Technology
- 50% Lower Q_{rr} than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- Low Profile 0.5 mm Maximum in MicroFET 2x2 mm
- 100% UIL Tested
- These Devices are Pb-Free and are RoHS Compliant

Typical Applications

- Primary DC-DC MOSFET
- Synchronous Rectifier in DC–DC and AC–DC
- Motor Drive

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-to-Source Voltage		V _{DSS}	120	V
Gate-to-Source Voltage		V _{GS}	±20	V
		۱ _D	4.5	A
Power Dissipation (Note 1) $T_A = 25^{\circ}C$		PD	2.1	W
Power Dissipation (Note 2) $T_A = 25^{\circ}C$		PD	0.62	W
Pulsed Drain Current (Note 3) $T_A = 25^{\circ}C$		I _{DM}	51	А
Operating Junction and Storage T Range	T _J , T _{stg}	–55 to +150	°C	
Single Pulse Drain-to-Source Avalanche Energy ($I_{L(pk)} = 4 A$) (Note 4)		E _{AS}	8	mJ
Maximum Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{\theta JA}$	60	°C/W
Thermal Resistance Junction-to-Ambient (Note 2)	R_{\thetaJA}	200	°C/W

1. Surface mounted on a FR-4 board using 1 in² pad of 2 oz copper.

- Surface mounted on a FR-4 board using the minimum recommended pad of 2 oz copper.
- 3. Pulsed ID please refer to Figure 11 SOA graph for more details
- 4. E_{AS} of 8 mJ is based on starting T_J = 25°C; L = 1 mH, I_{AS} = 4 A, V_{DD} = 120 V, V_{GS} = 10 V.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
120 \/	53 mΩ @ 10 V	4 5 A
120 V	70 m Ω @ 4.5 V	4.5 A

N-CHANNEL MOSFET





MARKING DIAGRAM



ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A	120			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I_D = 250 µA, referenced to 25°C		55		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V_{GS} = 0 V, V_{DS} = 96 V, T_{J} = 25°C			1	μA
Gate-to-Source Leakage Current	I _{GSS}	V_{GS} = ±20 V, V_{DS} = 0 V			±100	nA
ON CHARACTERISTICS (Note 5)						
Gate Threshold Voltage	V _{GS(TH)}	V_{GS} = V_{DS} , I_D = 30 μ A	1.0	1.5	3.0	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J	V_{GS} = V_{DS} , I_D = 30 μ A		-4.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V_{GS} = 10 V, I_D = 5.2 A, T_J = 25°C		42	53	mΩ
		V_{GS} = 4.5 V, I_{D} = 4.5 A, T_{J} = 25°C		55	70	mΩ
		V_{DS} = 10 V, I_{D} = 5.2 A, T_{J} = 125°C		71	90	mΩ
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C _{ISS}			520		pF
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz V _{DS} = 60 V		190		
Reverse Transfer Capacitance	C _{RSS}			1.8		
Gate-Resistance	R _G			2.0	3.0	Ω
Total Gate Charge	Q _{G(TOT)}			7.8		nC
4.5 V Gate Charge	Q _{G(4.5V)}			3.8		
Gate-to-Source Charge	Q _{GS}	$v_{GS} = 10 v, v_{DS} = 60 v, I_D = 5.2 A$		1.5		
Gate-to-Drain Charge	Q _{GD}			1.0		
Output Charge	Q _{OSS}	V_{GS} = 0 V, V_{DD} = 60 V		17		nC
Total Gate Charge Sync	Q _{SYNC}	V_{DS} = 0 V, V_{GS} = 0 ~ 10 V		6.7		nC
RESISTIVE SWITCHING CHARACTER	RISTICS (Note	6)				
Turn-On Delay Time	t _{d(on)}			5.9	12	ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS} = 60 V,		1.6	10	
Turn-Off Delay Time	t _{d(off)}	$I_D = 5.2 \text{ Å}, R_G = 6 \Omega$		14	25	
Fall Time	t _f			2.6	10	
DRAIN-SOURCE DIODE CHARACTERISTICS						
Forward Diode Voltage	V _{SD}	V_{GS} = 0 V, I_S = 5.2 A, T_J = 25°C		0.87	1.2	V
Reverse Recovery Time	t _{RR}			25	40	ns
Reverse Recovery Charge	Q _{RR}	ι _F = 5.2 A, αι _s /ατ = 300 A/μs		31	50	nC
Reverse Recovery Time	t _{RR}			15	26	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

 $I_F=5.2~\text{A},~\text{dI}_\text{s}/\text{dt}=1000~\text{A}/\mu\text{s}$

64

103

nC

5. Pulse test: pulse width \leq 300 µs, duty ratio \leq 2%.

Reverse Recovery Charge

6. Switching characteristics are independent of operating junction temperature

 $\mathsf{Q}_{\mathsf{R}\mathsf{R}}$

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



Figure 13. Junction-to-Ambient Transient Thermal Response Curve

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTLJS053N12MCLTAG	53	UDFN6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



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